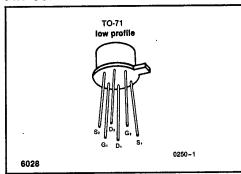
Monolithic Dual Cascoded N-Channel JFET General Purpose Amplifier

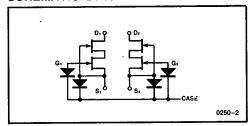
GENERAL DESCRIPTION

A low noise, low leakage FET that employs a cascode structure to accomplish very low IG at high voltage levels, while giving high transconductance and very high common, mode rejection ratio.

PIN CONFIGURATION



SCHEMATIC DIAGRAM



T-29-27

FEATURES

01

- C_{MRR} > 120dB
- I_G<5pA @ 50V_{DG}
- C₁₈₅<0.5pF
- g_{os}>.025μs

ABSOLUTE MAXIMUM RATINGS

| (T _A = 25°C unless otherwise specified) | |
|--|------|
| Drain-Source and Drain-Gate | |
| Voltages (Note 1) | 60V |
| Drain Current (Note 1) 5 | 0mA |
| Gate-Gate Voltage ± | :60V |
| Storage Temperature65°C to +20 | |
| Operating Temperature55°C to +1 | |
| Lead Temperature (Soldering, 10sec) +3 | |
| | |

| | One Side | Both Sides |
|----------------------------|----------|-------------------|
| Power Dissipation (Note 3) | 250mW | 500mW |
| Derate above 25°C | 3.8mW/°C | 7.7mW/°C |

NOTE 1. Per transistor.

NOTE 2. Due to the non-symmetrical structure of these devices, the drain and source ARE NOT interchangeable.

NOTE 3. @ 85°C free air temp.

NOTE: Stresses above those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions above those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

ORDERING INFORMATION

| | ١ |
|-------|---|
| TO-71 | ĺ |
| IT500 | l |
| IT501 | |
| IT502 | 1 |
| IT503 | ļ |
| IT504 | Ì |
| IT505 | 1 |

IT500-IT505

| | OO-IT505 RICAL CHARACTERISTICS (TA = 25°C) | unless otherwise specific | T- | | enne S - 2 | rsil 7 |
|----------------------|--|--|----------------------------------|-------|---------------|--------------|
| Symbol | Characteristics | Test Condition | ons | | Lin | its Units |
| | | | | Min | Max | |
| IGSS | Gate Reverse Current | $V_{GS} = -20V, V_{DS} = 0, 7$ | T _A =125°C | | 100 | pΑ |
| | | | | | -5 | nΑ |
| BVGSS | Gate-Source Breakdown Voltage | $I_G = -1 \mu A, V_{DS} = 0$ | | 50 | | |
| V _{GS(off)} | Gate-Source Cutoff Voltage | V _{DS} =20V, I _D =1nA | | -0.7 | -4 | V |
| V _{GS} | Gate-Source Voltage | | -0.2 | -3.8 | | |
| lg | Gate Operating Current | V _{DG} = 35V, I _D = 200μA, | | -5 | pΑ | |
| | | | | -5 | nA | |
| loss | Saturation Drain Current (Note 1) | V _{DS} =20V, V _{GS} =0 | 0.7 | 7 | mA | |
| 9fs | Common-Source Forward Transconductance (Note 1) | V _{DS} =20V, V _{GS} =0 | | 1000 | 4000 | |
| 9 fs | Common-Source Forward Transconductance (Note 1) | $V_{DG} = 20V, I_D = 200 \mu A$ | f=1kHz | 500 | 1600 | |
| gos | Common-Source Output Conductance | V _{DS} =20V, V _{GS} =0 | 1 | | 1 | μs |
| g _{os} | Common-Source Output Conductance | V _{DS} =20V, I _D =200μA | 1 | 0.025 | | |
| C _{g1g2} | Gate to Gate Capacitance (Note 4) | V _{G1} =V _{G2} =10V | | | 3.5 | pF |
| C _{iss} | Common-Source Input Capacitance (Note 4) | | f=1MHz | | 7 | |
| C _{rss} | Common-Source Reverse Transfer Capacitance (Note 3, 4) | V _{DS} =20V, V _{GS} =0 | | | 0.5 | pF |
| NF | Spot Noise Figure (Note 4) | | f=100Hz, R _G =10MΩ | | 0.5 | dВ |
| ē _n | Equivalent Input Noise Voltage (Note 4) | | f=10Hz | | 50 | <u>μ</u> V |
| | | | f=1kHz | | 15 | √Hz |

| Symbol | Characteristics | Test Con | ditions | ΙΤ | 500 | IT! | 501 | IT | 502 | IT: | 503 | IT! | 504 | IT: | 505 | Units |
|--|---|--|------------------|------|-----|------|-----|------|-----|------|-----|------|-----|------|-----|-------|
| | | | Min | Max | Min | Max | Min | Max | Min | Max | Min | Max | Min | Max | | |
| l _{G1} -l _{G2} | Differential Gate Current | V _{DG} = 20V, I _D = 200μΑ, Τ _Α | √=125°C | | 5 | | 5 | | 5 | | 5 | | 10 | | 15 | nA |
| I _{DSS1} I _{DSS2} | Saturation Drain Current Ratio (Note 1) | V _{DS} =20V, V _G | _S =0V | 0.95 | 1 | 0.95 | 1 | 0.95 | 1 | 0.95 | 1 | 0.9 | 1 | 0.85 | 1 | |
| 9fs1/9fs2 | Transconductance Ratio (Note 1) | | f=1kHz | 0.97 | 1 | 0.97 | 1 | 0.95 | 1 | 0.95 | 1 | 0.90 | 1 | 0.85 | 1 | |

T-29-27

ELECTRICAL CHARACTERISTICS (Continued) (TA = 25°C unless otherwise specified)

| - GO - GOZ | 01 | Test Conditions V _{DG} = 20V I _D = 200 μA | | IT: | 500 | 17501 | | IT502 | | IT | 503 | IT504 | | IT505 | | Units |
|---|--|--|---|-----|--------|-------|-----|-------|-----|-----|-----|-------|-----|-------|-----|-------|
| | Characteristics | | | Min | in Max | Min | Max | x Min | Max | Min | Max | Min | Max | Min | | |
| | Differential Gate- Source Voltage | | | | 5 | | 5 | | 10 | | 15 | | 25 | | 50 | mV |
| ΔV _{GS1} -V _{GS2} ΔT | Gate-Source Differ- ential Voltage | | T _A =25°C T _B =125°C | | 5 | | 10 | | 20 | | 40 | | 100 | | 200 | μV/°C |
| | Change with Temp. (Note 2, 4) | | $T_{A} = -55^{\circ}C$ $T_{B} = 25^{\circ}C$ | | 5 | | 10 | | 20 | | 40 | | 100 | | 200 | |
| C _{MRR} (Note 5) | Common Mode Rejection Ratio (Note 4) | Δ V _{DD} =10V, I | _D =200μA | 120 | | 120 | | 120 | | 120 | | 120 | | 120 | | dB |

NOTES: 1. Pulse test required, pulsewidth = 300 µs, duty cycle ≤ 3%.

IT500-IT505

- : 1, ruise test required, pulsewhorn=200/s, only cycles 3%.

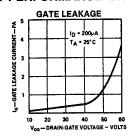
 2. Measured at end points, T_A and T_B.

 3. With case guarded C_{78s} is typically <0.15pF.

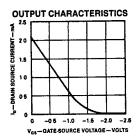
 4. For design reference only, not 100% tested.

 5. C_{MRR}=20 log₁₀ΔV_{DD}/Δ [V_{gs1}-V_{gs2}], ΔV_{DD}=10/-20V

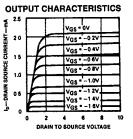
TYPICAL PERFORMANCE CHARACTERISTICS



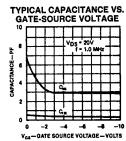
0250-4



0250~6



0250-5



0250-7

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